Low-ohmic single-pole double-throw analog switch Rev. 10.1 — 24 November 2020 Produc

Product data sheet

1 General description

The NX3L1G3157 is a low-ohmic single-pole double-throw analog switch suitable for use as an analog or digital 2:1 multiplexer/demultiplexer. It has a digital select input (S), two independent inputs/outputs (Y0 and Y1) and a common input/output (Z). Schmitt trigger action at the digital input makes the circuit tolerant to slower input rise and fall times.

The NX3L1G3157 allows signals with amplitude up to V_{CC} to be transmitted from Z to Y0 or Y1; or from Y0 or Y1 to Z. Its low ON resistance (0.5 Ω) and flatness (0.13 Ω) ensures minimal attenuation and distortion of transmitted signals.

2 Features and benefits

- Wide supply voltage range from 1.4 V to 4.3 V
- Very low ON resistance:
 - 1.6 Ω (typical) at V_{CC} = 1.4 V
 - 1.0 Ω (typical) at V_{CC} = 1.65 V
 - 0.55 Ω (typical) at V_{CC} = 2.3 V
 - 0.50 Ω (typical) at V_{CC} = 2.7 V
 - 0.50 Ω (typical) at V_{CC} = 4.3 V
- Break-before-make switching
- High noise immunity
- ESD protection:
 - HBM JESD22-A114F Class 3A exceeds 7500 V
 - MM JESD22-A115-A exceeds 200 V
 - CDM AEC-Q100-011 revision B exceeds 1000 V
 - IEC61000-4-2 contact discharge exceeds 8000 V for switch ports
- CMOS low-power consumption
- Latch-up performance exceeds 100 mA per JESD78 Class II Level A
- Direct interface with TTL levels at 3.0 V
- · Control input accepts voltages above supply voltage
- High current handling capability (350 mA continuous current under 3.3 V supply)
- Specified from -40 $^\circ\text{C}$ to +85 $^\circ\text{C}$ and from -40 $^\circ\text{C}$ to +125 $^\circ\text{C}$

3 Applications

- Cell phone
- PDA
- · Portable media player



Low-ohmic single-pole double-throw analog switch

Ordering information 4

Table 1. Ordering information									
Type number	Topside	Package	Package						
	marking ^[1]	Name	Description	Version					
NX3L1G3157GM	MJ	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 x 1.45 x 0.5 mm	SOT886					

[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

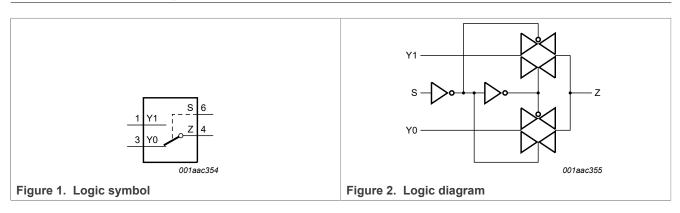
4.1 Ordering options

Table 2. Ordering options

Type number	Orderable part number	Package	Packing method	Minimum order quantity	Temperature
NX3L1G3157GM	NX3L1G3157GM,115 ^[1]	XSON6	REEL 7" Q1 NDP	5000	T _{amb} = -40 °C to +125 °C
NX3L1G3157GM	NX3L1G3157GMZ	XSON6	REEL 7" Q1 NDP SSB ^[2]	5000	T_{amb} = -40 °C to +125 °C

Will go EOL - migrate to new leadframe NX3L1G3157GMZ orderable part number This packing method uses a Static Shielding Bag (SSB) solution. Material is to be kept in the sealed bag between uses. [1] [2]

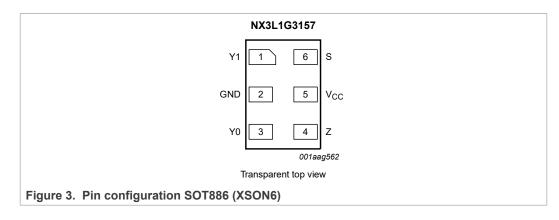
Functional diagram 5



Pinning information 6

Low-ohmic single-pole double-throw analog switch

6.1 Pinning



6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description	
Y1	1	independent input or output	
GND	2	ound (0 V)	
Y0	3	independent input or output	
Z	4	common output or input	
V _{CC}	5	supply voltage	
S	6	select input	

7 Functional description

Table 4. Function table^[1]

Input S	Channel on
L	Y0
Н	Y1

[1] H = HIGH voltage level; L = LOW voltage level.

8 Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+4.6	V
VI	input voltage	select input S	[1]	-0.5	+4.6	V
V _{SW}	switch voltage		[2]	-0.5	V _{CC} + 0.5	V
I _{IK}	input clamping current	V ₁ < -0.5 V		-50	-	mA
I _{SK}	switch clamping current	$V_{\rm I}$ < -0.5 V or $V_{\rm I}$ > $V_{\rm CC}$ + 0.5 V		-	±50	mA

Low-ohmic single-pole double-throw analog switch

Table 5. Limiting values...continued

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Мах	Unit
I _{SW}	switch current	V_{SW} > -0.5 V or V_{SW} < V_{CC} + 0.5 V; source or sink current		-	±350	mA
		V_{SW} > -0.5 V or V_{SW} < V_{CC} + 0.5 V; pulsed at 1 ms duration, < 10 % duty cycle; peak current		-	±500	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +125 °C	[3]	-	250	mW

[1] The minimum input voltage rating may be exceeded if the input current rating is observed.

[2] The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed but may not exceed 4.6 V.

[3] For XSON6 package: above 118 °C the value of P_{tot} derates linearly with 7.8 mW/K.

9 Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			1.4	4.3	V
VI	input voltage	select input S		0	4.3	V
V _{SW}	switch voltage		[1]	0	V _{CC}	V
T _{amb}	ambient temperature			-40	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 1.4 V to 4.3 V	[2]	-	200	ns/V

[1] To avoid sinking GND current from terminal Z when switch current flows in terminal Yn, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal Z, no GND current flows from terminal Yn. In this case, there is no limit for the voltage drop across the switch.

[2] Applies to control signal levels.

10 Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	T _{ar}	_{nb} = 25	°C	T _{amb} =	Unit		
			Min	Тур	Мах	Min	Max (85 °C)	Max (125 °C)	
V _{IH}	HIGH-level	V _{CC} = 1.4 V to 1.95 V	0.65V _{CC}	-	-	$0.65V_{CC}$	-	-	V
	input voltage	V _{CC} = 2.3 V to 2.7 V	1.7	-	-	1.7	-	-	V
		V _{CC} = 2.7 V to 3.6 V	2.0	-	-	2.0	-	-	V
		V _{CC} = 3.6 V to 4.3 V	0.7V _{CC}	-	-	0.7V _{CC}	-	-	V
V _{IL}	LOW-level	V _{CC} = 1.4 V to 1.95 V	-	-	$0.35V_{CC}$	-	$0.35V_{CC}$	$0.35V_{CC}$	V
	input voltage	V _{CC} = 2.3 V to 2.7 V	-	-	0.7	-	0.7	0.7	V
		V _{CC} = 2.7 V to 3.6 V	-	-	0.8	-	0.8	0.8	V
		V _{CC} = 3.6 V to 4.3 V	-	-	0.3V _{CC}	-	0.3V _{CC}	0.3V _{CC}	V
I	input leakage current	select input S; V_1 = GND to 4.3 V; V_{CC} = 1.4 V to 4.3 V	-	-	-	-	±0.5	±1	μA
NX3L1G3157		All information provided in t	this document is subject	to legal discl	aimers.	1	© NXP	B.V. 2020. All righ	ts reserved

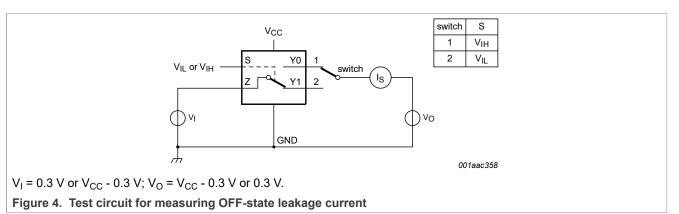
Low-ohmic single-pole double-throw analog switch

Table 7. Static characteristics...continued

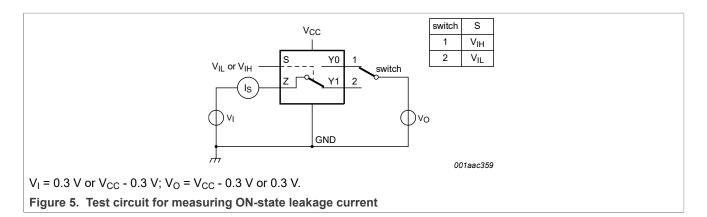
At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	Ta	T _{amb} = 25 °C			T _{amb} = -40 °C to +125 °C			
			Min	Тур	Мах	Min	Max (85 °C)	Max (125 °C)		
I _{S(OFF)}	leakage	Y0 and Y1 port; see Figure 4								
	current	V _{CC} = 1.4 V to 3.6 V	-	-	±5	-	±50	±500	nA	
		V _{CC} = 3.6 V to 4.3 V	-	-	±10	-	±50	±500	nA	
I _{S(ON)}	I _{S(ON)} ON-state leakage current	Z port; see Figure 5								
		V _{CC} = 1.4 V to 3.6 V	-	-	±5	-	±50	±500	nA	
		V _{CC} = 3.6 V to 4.3 V	-	-	±10	-	±50	±500	nA	
I _{CC}	supply current	$V_{I} = V_{CC}$ or GND; $V_{SW} =$ GND or V_{CC}								
		V _{CC} = 3.6 V	-	-	100	-	690	6000	nA	
		V _{CC} = 4.3 V	-	-	150	-	800	7000	nA	
CI	input capacitance		-	1.0	-	-	-	-	pF	
C _{S(OFF)}	OFF-state capacitance		-	35	-	-	-	-	pF	
C _{S(ON)}	ON-state capacitance		-	130	-	-	-	-	pF	

10.1 Test circuits



Low-ohmic single-pole double-throw analog switch



10.2 ON resistance

Table 8. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for graphs see Figure 7 to Figure 13.

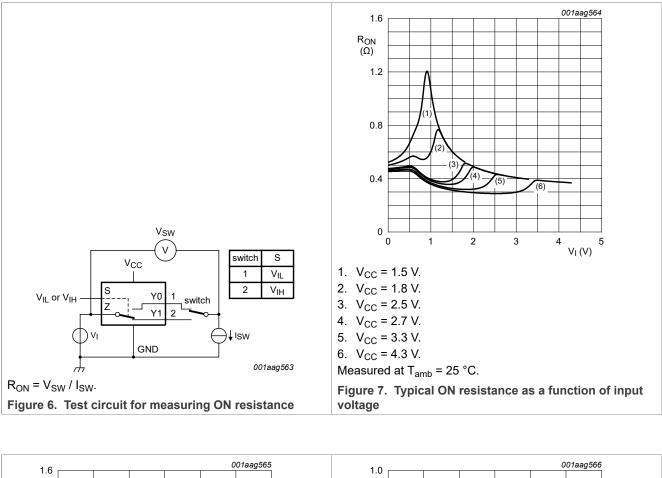
Symbol	Parameter	Conditions		T _{amb} =	-40 °C to	+85 °C	T _{amb} = -40 °	Unit	
				Min	Typ ^[1]	Мах	Min	Max	
R _{ON(peak)}	ON resistance (peak)	V_{I} = GND to V_{CC} ; I_{SW} = 100 mA; see <u>Figure 6</u>							
		V _{CC} = 1.4 V		-	1.6	3.7	-	4.1	Ω
		V _{CC} = 1.65 V		-	1.0	1.6	-	1.7	Ω
		V _{CC} = 2.3 V		-	0.55	0.8	-	0.9	Ω
		V _{CC} = 2.7 V		-	0.5	0.75	-	0.9	Ω
		V _{CC} = 4.3 V		-	0.5	0.75	-	0.9	Ω
ΔR _{ON} ON resistance mismatch between	$V_I = GND$ to V_{CC} ; $I_{SW} = 100 \text{ mA}$	[2]							
	channels	V _{CC} = 1.4 V		-	0.04	0.3	-	0.3	Ω
		V _{CC} = 1.65 V		-	0.04	0.2	-	0.3	Ω
		V _{CC} = 2.3 V		-	0.02	0.08	-	0.1	Ω
		V _{CC} = 2.7 V		-	0.02	0.075	-	0.1	Ω
		V _{CC} = 4.3 V		-	0.02	0.075	-	0.1	Ω
R _{ON(flat)}	ON resistance (flatness)	$V_I = GND$ to V_{CC} ; $I_{SW} = 100 \text{ mA}$	[3]						
		V _{CC} = 1.4 V		-	1.0	3.3	-	3.6	Ω
		V _{CC} = 1.65 V		-	0.5	1.2	-	1.3	Ω
		V _{CC} = 2.3 V		-	0.15	0.3	-	0.35	Ω
		V _{CC} = 2.7 V		-	0.13	0.3	-	0.35	Ω
		V _{CC} = 4.3 V		-	0.2	0.4	-	0.45	Ω

[1]

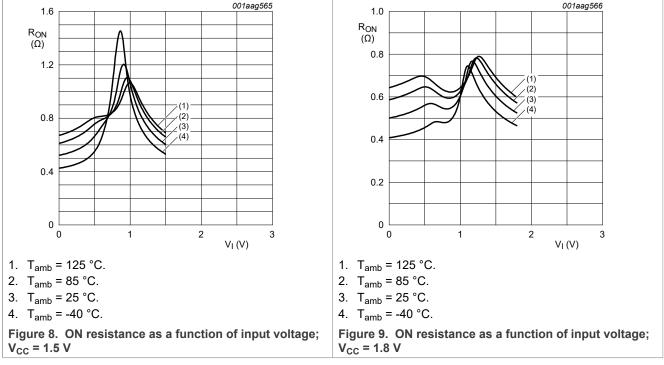
[2] [3]

Typical values are measured at $T_{amb} = 25$ °C. Measured at identical V_{CC}, temperature and input voltage. Flatness is defined as the difference between the maximum and minimum value of ON resistance measured at identical V_{CC} and temperature.

Low-ohmic single-pole double-throw analog switch



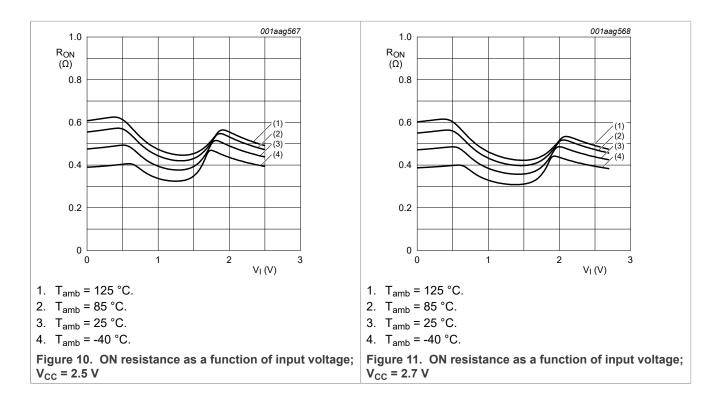
10.3 ON resistance test circuit and graphs

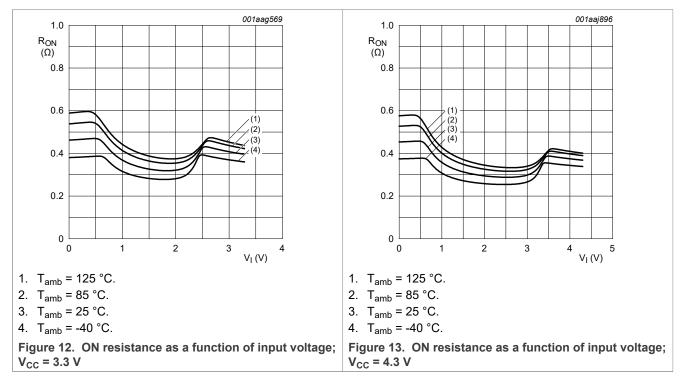


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Low-ohmic single-pole double-throw analog switch





Low-ohmic single-pole double-throw analog switch

11 Dynamic characteristics

Table 9. Dynamic characteristics

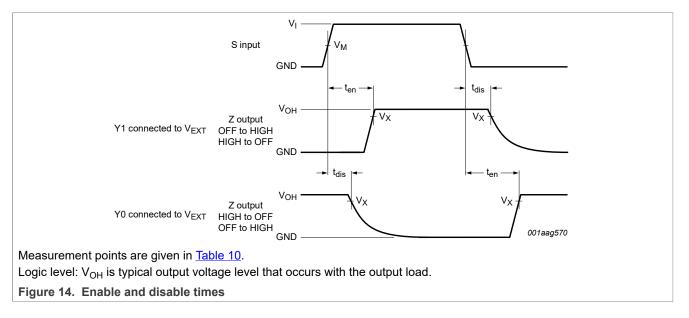
At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for load circuit see Figure 16.

Symbol	Parameter	Conditions		Т	_{amb} = 25 °	°C	T _{amb} =	= -40 °C to +	+125 °C	Unit
				Min	Тур ^[1]	Max	Min	Max (85 °C)	Max (125 °C)	
t _{en}	enable time	S to Z or Yn; see Figure 14								
		V _{CC} = 1.4 V to 1.6 V		-	28	43	-	48	52	ns
		V_{CC} = 1.65 V to 1.95 V		-	23	35	-	38	42	ns
		V _{CC} = 2.3 V to 2.7 V		-	17	27	-	29	32	ns
		V _{CC} = 2.7 V to 3.6 V		-	14	25	-	27	30	ns
		V _{CC} = 3.6 V to 4.3 V		-	14	25	-	27	30	ns
t _{dis}	disable time	S to Z or Yn; see Figure 14								
		V _{CC} = 1.4 V to 1.6 V		-	9	20	-	25	30	ns
		V_{CC} = 1.65 V to 1.95 V		-	6	15	-	20	23	ns
		V _{CC} = 2.3 V to 2.7 V		-	5	11	-	14	16	ns
		V _{CC} = 2.7 V to 3.6 V		-	4	10	-	12	14	ns
		V _{CC} = 3.6 V to 4.3 V		-	4	10	-	12	14	ns
t _{b-m}	break-before-make	see Figure 15	[2]							
	time	V _{CC} = 1.4 V to 1.6 V		-	19	-	4	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		-	17	-	4	-	-	ns
		V _{CC} = 2.3 V to 2.7 V		-	13	-	2	-	-	ns
		V _{CC} = 2.7 V to 3.6 V		-	10	-	2	-	-	ns
		V _{CC} = 3.6 V to 4.3 V		-	10	-	2	-	-	ns

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 1.5 V, 1.8 V, 2.5 V, 3.3 V and 4.3 V respectively.

[2] Break-before-make guaranteed by design.

Low-ohmic single-pole double-throw analog switch

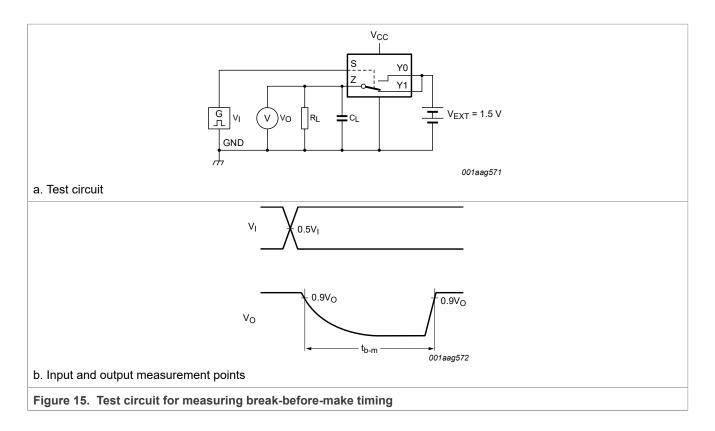


11.1 Waveform and test circuits

Table 10. Measurement points

Supply voltage	Input	Output
V _{cc}	V _M	V _X
1.4 V to 4.3 V	0.5V _{CC}	0.9V _{OH}

Low-ohmic single-pole double-throw analog switch



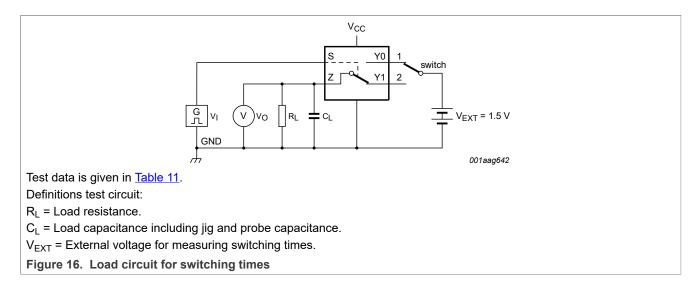


Table 11. Test data

Supply voltage	Input		Load	
V _{cc}	VI	t _r , t _f	CL	RL
1.4 V to 4.3 V	V _{CC}	≤ 2.5 ns	35 pF	50 Ω

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Low-ohmic single-pole double-throw analog switch

11.2 Additional dynamic characteristics

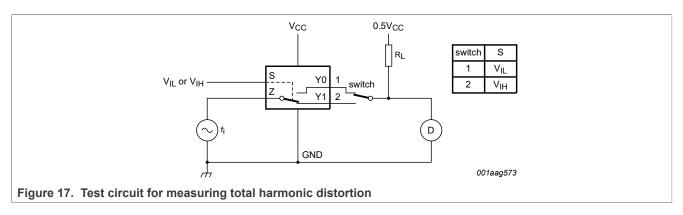
Table 12. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $V_I = GND$ or V_{CC} (unless otherwise specified); $t_r = t_f \le 2.5$ ns; $T_{amb} = 25$ °C.

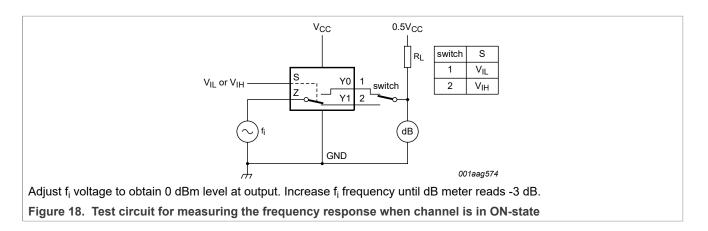
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
	total harmonic	f_i = 20 Hz to 20 kHz; R_L = 32 Ω; see Figure 17	[1]				
	distortion	V _{CC} = 1.4 V; V _I = 1 V (p-p)		-	0.15	-	%
		V _{CC} = 1.65 V; V _I = 1.2 V (p-p)		-	0.10	-	%
		V _{CC} = 2.3 V; V _I = 1.5 V (p-p)		-	0.02	-	%
		V _{CC} = 2.7 V; V _I = 2 V (p-p)		-	0.02	-	%
		V _{CC} = 4.3 V; V _I = 2 V (p-p)		-	0.02	-	%
f _(-3dB)	-3 dB frequency	R_L = 50 Ω; see <u>Figure 18</u>	[1]				
	response	V _{CC} = 1.4 V to 4.3 V		-	60	-	MHz
α_{iso} isolation (OFF-state)	isolation (OFF-state)	f_i = 100 kHz; R_L = 50 Ω ; see <u>Figure 19</u>	[1]				
		V _{CC} = 1.4 V to 4.3 V		-	-90	-	dB
V _{ct} crosstalk voltage	crosstalk voltage	between digital inputs and switch; f _i = 1 MHz; C _L = 50 pF; R _L = 50 Ω ; see Figure 20					
		V _{CC} = 1.4 V to 3.6 V		-	0.2	-	V
		V _{CC} = 3.6 V to 4.3 V		-	0.3	-	V
Q _{inj} charge injection	charge injection	f_i = 1 MHz; C _L = 0.1 nF; R _L = 1 MΩ; V _{gen} = 0 V; R _{gen} = 0 Ω; see Figure 21					
		V _{CC} = 1.5 V		-	3	-	рС
		V _{CC} = 1.8 V		-	4	-	рС
		V _{CC} = 2.5 V		-	6	-	рС
		V _{CC} = 3.3 V		-	9	-	рС
		V _{CC} = 4.3 V		-	15	-	рС

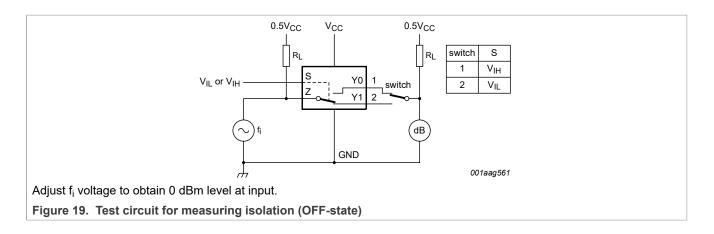
[1] f_i is biased at 0.5V_{CC}.

11.3 Test circuits

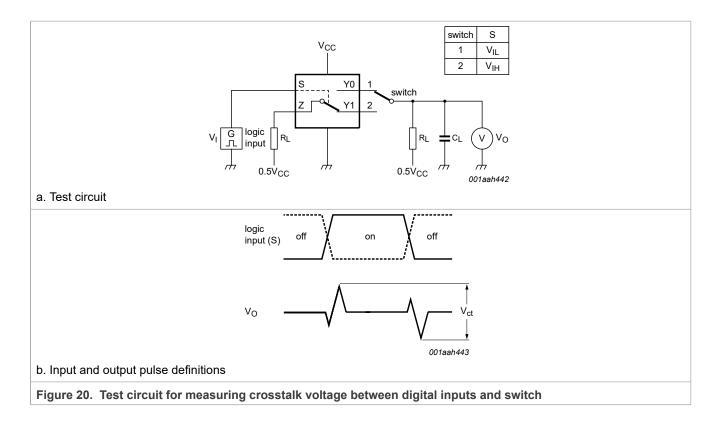


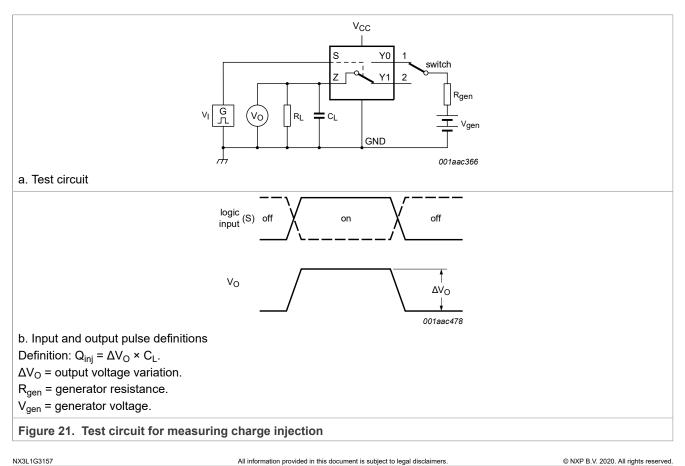
Low-ohmic single-pole double-throw analog switch





Low-ohmic single-pole double-throw analog switch





Low-ohmic single-pole double-throw analog switch

12 Package outline

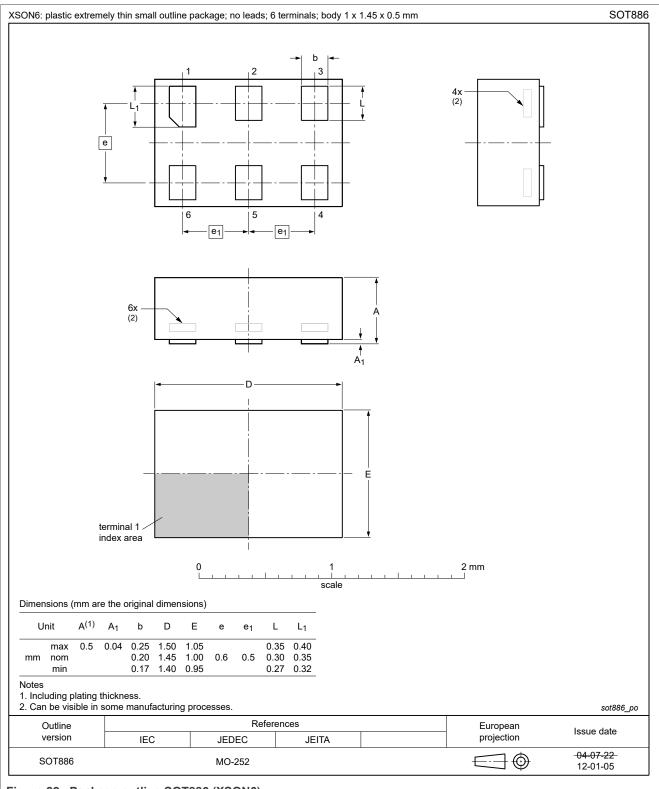


Figure 22. Package outline SOT886 (XSON6)

Low-ohmic single-pole double-throw analog switch

13 Abbreviations

Table 13. Abbreviations			
Acronym	Description		
CDM	Charged Device Model		
CMOS	Complementary Metal-Oxide Semiconductor		
ESD	ElectroStatic Discharge		
НВМ	Human Body Model		
ММ	Machine Model		
PDA	Personal Digital Assistant		
TTL	Transistor-Transistor Logic		

14 Revision history

Table 14. Revision his	story			
Document ID	Release date	Data sheet status	Change notice	Supersedes
NX3L1G3157 v.10.1	20201124	Product data sheet	-	NX3L1G3157 v.10
Modifications:	Assembly/Test	886 requiring SSB added. Refe Transfer from ATGD and ATSI L1G3157GW,125		1909001 XSON6 (SOT886
NX3L1G3157 v.10	20120807	Product data sheet	-	NX3L1G3157 v.9
Modifications:	 Package outling 	e drawing of SOT886 (Figure 2	22) modified.	
NX3L1G3157 v.9	20111109	Product data sheet	-	NX3L1G3157 v.8
Modifications:	 Legal pages u 	pdated.	·	
NX3L1G3157 v.8	20100426	Product data sheet	-	NX3L1G3157 v.7
NX3L1G3157 v.7	20100324	Product data sheet	-	NX3L1G3157 v.6
NX3L1G3157 v.6	20100208	Product data sheet	-	NX3L1G3157 v.5
NX3L1G3157 v.5	20090407	Product data sheet	-	NX3L1G3157 v.4
NX3L1G3157 v.4	20080730	Product data sheet	-	NX3L1G3157 v.3
NX3L1G3157 v.3	20080721	Product data sheet	-	NX3L1G3157 v.2
NX3L1G3157 v.2	20080415	Product data sheet	-	NX3L1G3157 v.1
NX3L1G3157 v.1	20071008	Product data sheet	-	-

Low-ohmic single-pole double-throw analog switch

15 Legal information

15.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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Low-ohmic single-pole double-throw analog switch

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Tables

Tab. 1.	Ordering information	2
Tab. 2.	Ordering options	2
Tab. 3.	Pin description	3
Tab. 4.	Function table	3
Tab. 5.	Limiting values	3
Tab. 6.	Recommended operating conditions	4
Tab. 7.	Static characteristics	4

Figures

Fig. 1.	Logic symbol	2
Fig. 2.	Logic diagram	
Fig. 3.	Pin configuration SOT886 (XSON6)	
Fig. 4.	Test circuit for measuring OFF-state	
	leakage current	5
Fig. 5.	Test circuit for measuring ON-state leakage	
	current	
Fig. 6.	Test circuit for measuring ON resistance	.7
Fig. 7.	Typical ON resistance as a function of input	
	voltage	.7
Fig. 8.	ON resistance as a function of input	
	voltage; VCC = 1.5 V	.7
Fig. 9.	ON resistance as a function of input	
	voltage; VCC = 1.8 V	.7
Fig. 10.	ON resistance as a function of input	
	voltage; VCC = 2.5 V	.8
Fig. 11.	ON resistance as a function of input	
	voltage; VCC = 2.7 V	.8

Tab. 8.	ON resistance	6
Tab. 9.	Dynamic characteristics	9
Tab. 10.	Measurement points	10
Tab. 11.	Test data	11
Tab. 12.	Additional dynamic characteristics	12
Tab. 13.	Abbreviations	16
Tab. 14.	Revision history	16

Fig. 12.	ON resistance as a function of input	
	voltage; VCC = 3.3 V	8
Fig. 13.	ON resistance as a function of input	
	voltage; VCC = 4.3 V	8
Fig. 14.	Enable and disable times	10
Fig. 15.	Test circuit for measuring break-before-	
U U	make timing	11
Fig. 16.	Load circuit for switching times	11
Fig. 17.	Test circuit for measuring total harmonic	
	distortion	12
Fig. 18.	Test circuit for measuring the frequency	
-	response when channel is in ON-state	13
Fig. 19.	Test circuit for measuring isolation (OFF-	
U U	state)	13
Fig. 20.	Test circuit for measuring crosstalk voltage	
•	between digital inputs and switch	14
Fig. 21.	Test circuit for measuring charge injection	
Fig. 22.	Package outline SOT886 (XSON6)	
-	5	

Low-ohmic single-pole double-throw analog switch

Contents

General description	1
Ordering information	2
Ordering options	2
Functional diagram	2
Functional description	3
Static characteristics	4
Test circuits	5
ON resistance	6
ON resistance test circuit and graphs	7
Dynamic characteristics	9
Waveform and test circuits	10
Additional dynamic characteristics	12
Package outline	15
Revision history	16
Legal information	17
	General description Features and benefits Applications Ordering information Ordering options Functional diagram Pinning information Pin description Functional description Functional description Imiting values Recommended operating conditions Static characteristics Test circuits ON resistance test circuit and graphs Dynamic characteristics Waveform and test circuits Additional dynamic characteristics Test circuits Package outline Abbreviations Revision history Legal information

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Date of release: 24 November 2020 Document identifier: NX3L1G3157

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